

10/585295  
IAP20 Rec'd PCT/PTO 06 JUL 2006

S/N Unknown

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

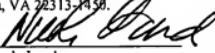
Applicant: YAMAOKA et al. Examiner: Unknown  
Serial No.: Unknown Group Art Unit: Unknown  
Filed: 6 July 2006 Docket: 10921.412USWO  
Title: ANALYTICAL INSTRUMENT HAVING IMPROVED  
ARRANGEMENT OF REAGENT SECTION AND  
ANALYTICAL METHOD

CERTIFICATE UNDER 37 CFR 1.10

Express Mail mailing label number: EV858802926US

Date of Deposit: 6 July 2006

I hereby certify that the papers listed below are being deposited with the United States Postal Service Express Mail Post Office to Addressee service under 37 CFR 1.107 in an envelope addressed to: Mail Stop PCT, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

By:   
Name: Nicole Landree

INFORMATION DISCLOSURE STATEMENT (37 C.F.R. § 1.97(c))

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Dear Sir:

With regard to the above-identified application, the items of information listed on the enclosed Form 1449 are brought to the attention of the Examiner.

This statement should be considered because it is submitted within three months of the filing date of the above-identified application, which is not an application under 37 C.F.R. §1.53(d). Accordingly, no fee is due for consideration of the items listed on the enclosed Form 1449.

In accordance with 37 C.F.R. §1.98(a)(2), a copy of each foreign document or other information listed on the enclosed Form 1449 is provided. As this application was filed after June 30, 2003, copies of the cited U.S. Patent Documents are not included.

Applicants respectfully bring to the Examiner's attention that seven of the references listed on the enclosed Form 1449 were sited in an International Search Report, enclosed herewith.

A concise explanation of the relevance of each non-English language document or other information is as follows (37 C.F.R. §(a)(3)):

US 2004/0173458 corresponds to WO 03/008956. US 6,821,410 corresponds to JP 2002-333420. US 2004/0142406 corresponds to WO 03/057905. EP 1 615 031 corresponds to WO 2004/092725. US 6,541,861 corresponds to JP 2002-175699. US 5,320,732 corresponds to JP 4-357449. US 2005/0036906 corresponds to JP 2004-101519.

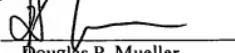
No representation is made that a reference is "prior art" within the meaning of 35 U.S.C. §§ 102 and 103 and Applicants reserve the right, pursuant to 37 C.F.R. § 1.131 or otherwise, to establish that the reference(s) are not "prior art." Moreover, Applicants do not represent that a reference has been thoroughly reviewed or that any relevance of any portion of a reference is intended.

Consideration of the items listed is respectfully requested. Pursuant to the provisions of M.P.E.P. 609, it is requested that the Examiner return a copy of the attached Form 1449, marked as being considered and initialed by the Examiner, to the undersigned with the next official communication.

Please charge any additional fees or credit any overpayment to Deposit Account No. 50-3478.

Respectfully submitted,

HAMRE, SCHUMANN, MUELLER &  
LARSON, P.C.  
P.O. Box 2902-0902  
Minneapolis, MN 55402-0902  
(612) 458-3800

Dated: 6 July 2006  
By:   
Douglas P. Mueller  
Reg. No. 30,300

DPM:hjm

<b>FORM 1449*</b> <b>INFORMATION DISCLOSURE STATEMENT</b> <b>IN AN APPLICATION</b> <small>(Use several sheets if necessary)</small>	Docket Number: 10921.412USWO <b>10/585295</b>	Application Number: Information
	Applicant: YAMAOKA et al.	
	Filing Date: 6 July 2006	Group Art Unit: Unknown

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/A.N./	2004/0173458 A1	9 Sept. 2004	NODA et al.			
/A.N./	6 821 410	23 Nov. 2004	WATANABE et al.			
/A.N./	2004/0142406 A1	22 July 2004	NAGAKAWA et al.			
/A.N./	6 541 861	1 April 2003	HIGASHI et al.			
/A.N./	5 320 732	14 June 1994	NANKAI et al.			
/A.N./	2005/0036906 A1	17 Feb. 2005	NAKAHARA et al.			

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
/A.N./	WO 03/008956	30 Jan. 2003	WIPO			US 2004/0173458	
/A.N./	JP 2002-333420	22 Nov. 2002	Japan			US 6,821,410	
/A.N./	WO 03/057905	17 July 2003	WIPO			US 2004/0142406	
/A.N./	WO 2004/092725	28 Oct. 2004	WIPO			EP 1 615 031	
/A.N./	EP 1 615 031	11 Nov. 2006	EPO				
/A.N./	JP 2002-175699	21 June 2002	Japan			US 6,541,861	
/A.N./	JP 4-357449	10 Dec. 1002	Japan			US 5,320,732	
/A.N./	JP 2004-101519	2 April 2004	Japan			US 2005/0036906	

**OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

52835

PATENT TRADEMARK OFFICE

**EXAMINER** /Alexander Noguerola/ **DATE CONSIDERED** 07/17/2009  
**EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form for next communication to the Applicant.